

Notice of References Cited	Application/Control No. 10/768,039		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner Allan Olsen		Art Unit 1763	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,866,434 A	02-1999	Massey et al.	436/526
*	B	US-6,203,814 B1	03-2001	Fisher et al.	424/443
*	C	US-2002/0008956 A1	01-2002	Niu, Chun-Ming	361/502
*	D	US-2003/0039604 A1	02-2003	Niu et al.	423/447.1
*	E	US-2003/0211028 A1	11-2003	Smalley et al.	423/447.1
*	F	US-6,712,864 B2	03-2004	Horiuchi et al.	23/314
*	G	US-2004/0101634 A1	05-2004	Park et al.	427/558
*	H	US-2004/0222081 A1	11-2004	Tour et al.	204/157.15
*	I	US-2005/0002850 A1	01-2005	Niu et al.	423/447.1
*	J	US-2005/0040371 A1	02-2005	Watanabe et al.	252/500
*	K	US-2005/0064647 A1	03-2005	Manabe et al.	438/222
*	L	US-6,946,410 B2	09-2005	French et al.	438/800
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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